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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/895,791	06/29/2001	Richard C. Flagan	41994/RAG/C766	5582	
23363 75	590 05/22/2003				
CHRISTIE, PARKER & HALE, LLP			EXAMINER		
350 WEST CO SUITE 500	LORADO BOULEVARD)	BOOTH, RICHARD A		
PASADENA, O	CA 91105		ART UNIT PAPER NUMBER		
			2812		
			DATE MAILED: 05/22/2003	DATE MAILED: 05/22/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

			D.2	<u> </u>		
τ		Application No.	Applicant(s)			
Office Action Summary		09/895,791	FLAGAN ET AL.			
		Examiner	Art Unit			
		Richard A. Booth	2812			
Period fo	- The MAILING DATE of this communication app r Reply	pears on the cover s	neet with the correspondence address			
THE N - Exten after S - If the - If NO - Failur - Any re	DRTENED STATUTORY PERIOD FOR REPLINALING DATE OF THIS COMMUNICATION. Is sions of time may be available under the provisions of 37 CFR 1.1 SIX (6) MONTHS from the mailing date of this communication. Deriod for reply specified above is less than thirty (30) days, a repliperiod for reply is specified above, the maximum statutory period to to reply within the set or extended period for reply will, by statute the ply received by the Office later than three months after the mailing displacement. See 37 CFR 1.704(b).	36(a). In no event, however y within the statutory minimu will apply and will expire SIX e, cause the application to be	may a reply be timely filed on of thirty (30) days will be considered timely. (6) MONTHS from the mailing date of this communication. come ABANDONED (35 U.S.C. § 133).			
1)⊠	Responsive to communication(s) filed on 04 i	<u> March 2003</u> .				
2a) <u></u>	This action is FINAL . 2b)⊠ Th	nis action is non-fina	i.			
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.						
·	on of Claims					
/	Claim(s) $1-44$ is/are pending in the application					
4	4a) Of the above claim(s) 11,13,14,36-39 and 44 is/are withdrawn from consideration.					
5)	5) Claim(s) is/are allowed.					
6)⊠ Claim(s) <u>1-10,12,15-35 and 40-43</u> is/are rejected.						
7)	7) Claim(s) is/are objected to.					
8) Claim(s) are subject to restriction and/or election requirement.						
l ''	on Papers					
, —	The specification is objected to by the Examine		to but the Francisco			
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
11)☐ The proposed drawing correction filed on is: a)☐ approved b)☐ disapproved by the Examiner. If approved, corrected drawings are required in reply to this Office action.						
12\[]	The oath or declaration is objected to by the Ex	-	1.			
,		Carriller.				
	nder 35 U.S.C. §§ 119 and 120	n mainaibu undos 25 l	1 S C S 110(a) (d) or (f)			
	Acknowledgment is made of a claim for foreign	n priority under 35 C	1.5.C. § 119(a)-(d) of (1).			
a)L	☐ All b)☐ Some * c)☐ None of:		- 4			
	1. Certified copies of the priority document					
	2. Certified copies of the priority document			•		
	 Copies of the certified copies of the prio application from the International Bu ee the attached detailed Office action for a list 	ireau (PCT Rule 17.	2(a)). ´			
 14)⊟ A	cknowledgment is made of a claim for domest	ic priority under 35 l	J.S.C. § 119(e) (to a provisional application)).		
	☐ The translation of the foreign language process	* *				
Attachment	(s)					
2) Notice 3) Inform	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) 🔲 N	terview Summary (PTO-413) Paper No(s) otice of Informal Patent Application (PTO-152) ther:			
U.S. Patent and Tr PTO-326 (Re		ction Summary	Part of Paper No. 9			

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DETAILED ACTION

Election/Restrictions

Applicant's election without traverse of the inventions directed to the particles being semiconductors, the deposition method of pyrolysis, and thermal growth in Paper No. 8 is acknowledged. Furthermore, it should be noted that claim 14 is dependent on claim 13 and both are directed to the non-elected embodiments. Therefore, the elected claims are claims 1-10, 12, 15-35, and 40-43.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

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Claims 1-10, 12, 15-24, 32, and 34-35 are rejected under 35 U.S.C. 103(a) as being unpatentable over Canata et al., "Size Classification of silicon nanocrystals" in view of Wu et al., "A Method for the Synthesis of Submicron Particles" and further in view of Littau et al. "A Luminescent Silicon Nanocrystal Colloid via a High-Temperature Aerosol Reaction".

Canata et al. shows the invention substantially as claimed including a method for forming a stratum consisting of semiconductor particles, comprising the steps of: forming an original plurality of discrete semiconductor particles from one of a source of semiconductor material (see nanocrystal source of fig. 1) and a precursor for said semiconductor material, said original plurality of discrete semiconductor particles entrained in a gas and thereby forming an aerosol; classifying particles of said plurality of semiconductor particles having diameters within the range of 3-10 nanometers; and depositing said semiconductor particles on a substrate thereby forming a stratum of discrete, electrically isolated semiconductor particles on the substrate (see abstract and entire document).

Canata et al. fails to expressly disclose heating said aerosol to a sufficiently high temperature to densify said particles such that substantially all of said particles includes a density substantially as great as the bulk density of said semiconductor material and thereby forming a corresponding plurality of densified discrete semiconductor particles entrained in a gas, and forming an electrically insulating cover on each of said particles, thereby forming a corresponding plurality of insulator coated densified discrete semiconductor particles.

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Littau et al. discloses a pyrolysis oven used to form the nanoparticles and a second oxidation oven used to form an oxide coating on the particles (see fig. 1 and section A, "Aerosol Apparatus"). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Canata et al. so as to form an electrically insulating cover on the nanoparticles as disclosed by Wu et al. because this is an effective method to oxidize the nanocrystals prior to their deposition on the substrate. Furthermore, Wu et al. discloses an aerosol forming reactor composed of sections in which the particles are heated to a sufficiently high temperature to densify said particles such that substantially all of said particles includes a density substantially as great as the bulk density of said semiconductor material and thereby forming a corresponding plurality of densified discrete semiconductor particles entrained in a gas (see temperature of zone 4 in fig. 1). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Canata et al. so as to include the sintering step of Wu et al. because this allows for the formation of a suitable aerosol for subsequent deposition on a substrate.

Claims 25-28, 33, and 40-43 are rejected under 35 U.S.C. 103(a) as being unpatentable over Canata et al., "Size Classification of silicon nanocrystals" in view of Wu et al., "A Method for the Synthesis of Submicron Particles" and further in view of Littau et al. "A Luminescent Silicon Nanocrystal Colloid via a High-Temperature Aerosol Reaction" as applied to claims 1-10, 12, 15-24, 32, and 34-35 above, and further in view of Yadav et al., U.S. Patent 6,344,271.

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Canata et al., Littau et al., and Wu et al. are applied as above but fail to expressly disclose using thermophoretic or electrophoretic deposition to form the nanoparticles. Yadav et al. discloses forming nanoparticles using either of the above mentioned deposition processes (see col. 14-lines 50-67). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Canata et al. modified by Wu et al. and Littau et al. so as to utilize the deposition processes of Yadav et al. because Yadav et al. shows these processes to be suitable processes to form nanoparticles.

Claims 29-32 are rejected under 35 U.S.C. 103(a) as being unpatentable over Canata et al., "Size Classification of silicon nanocrystals" in view of Wu et al., "A Method for the Synthesis of Submicron Particles" and further in view of Littau et al. "A Luminescent Silicon Nanocrystal Colloid via a High-Temperature Aerosol Reaction" as applied to claims 1-10, 12, 15-24, 32, and 34-35 above, and further in view of Tiwari et al., "Volatile and Non-Volatile Memories in Silicon with Nano-Crystal Storage".

Canata et al., Littau et al., and Wu et al. are applied as above but fail to expressly disclose implementing the nanoparticles in an eprom including a tunnel oxide, a gate dielectric film over said stratum, and a gate electrode over the gate dielectric film.

Tiwari et al. discloses a nanoparticle based memory including a monolayer of nanoparticles on a tunnel oxide, a gate oxide over the nanoparticles, and a control electrode over the control oxide (see fig. 1). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Canata et al. modified by Wu et al. and Littau et al. so as to

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implement the process into a non-volatile memory as suggested by Tiwari et al. because such memories can have a higher integration capability than conventional memory structures (see abstract).

Claims 34-35 are rejected under 35 U.S.C. 103(a) as being unpatentable over Canata et al., "Size Classification of silicon nanocrystals" in view of Wu et al., "A Method for the Synthesis of Submicron Particles" and further in view of Littau et al. "A Luminescent Silicon Nanocrystal Colloid via a High-Temperature Aerosol Reaction" as applied to claims 1-10, 12, 15-24, 32, and 34-35 above, and further in view of Junno et al., "Controlled Manipulation of nanoparticles with an atomic force microscope".

Canata et al., Littau et al., and Wu et al. are applied as above but fail to expressly disclose forming an ordered structure of nanoparticles using an atomic force microscope.

Junno et al. discloses using an atomic force microscope in order to position nanoparticles with high precision (see abstract). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Canata et al. modified by Wu et al. and Littau et al. so as to use an atomic force microscope to position the nanoparticles as suggested by Junno et al. because this allows for greater control of the formation of device features on the substrate.

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Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Richard A. Booth whose telephone number is 308-3446. The examiner can normally be reached on Monday-Thursday from 7:30-6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Niebling can be reached on 308-3325. The fax phone numbers for the organization where this application or proceeding is assigned are 308-7724 for regular communications and 308-7724 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 308-1782.

Richard A. Booth Primary Examiner Art Unit 2812

May 19, 2003